



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994 & ANSI/NCSL Z540.3-2006

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CALIBRATION

Valid To: March 31, 2023

Certificate Number: 2046.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations^{1,7}:

I. Acoustical Quantities

Parameter/Equipment	Range	CMC ^{2, 8} (\pm)	Comments
Sound Pressure Level ³ – Measurement Equipment	74 dB 84 dB 94 dB 104 dB 114 dB	0.41 dB 0.46 dB 0.48 dB 0.49 dB 0.42 dB	Sound level calibrator

II. Chemical Quantities

Parameter/Equipment	Range	CMC ^{2, 4, 5, 8} (\pm)	Comments
pH ³ – Measuring Equipment	(4, 7, 10) pH	0.015 pH units + 0.60R	Standard solutions w/comparison probe
	(0 to 14) pH	0.015 pH units + 0.60R	Fluke 5520A
Conductivity ³ – Measuring Equipment	100 μ S to 100 mS	1.2 % + 0.60R	Standard solutions w/comparison probe

III. Device Specific Parameters

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
ESD Simulator –			
Contact Discharge (Positive & Negative)	(2 to 8) kV	1.0 %	Brandenberg 139
Rise Time	(0.7 to 1) ns	0.12 ns	Oscilloscope and ESD target
30 nS Current	(2.8 to 20.8) A	1.8 %	IEC 61000-4-2, IEC 61000-4-2 (2001-04)
60 nS Current	(1 to 10) A	1.8 %	
EFT/Burst Generator ³ –			
Voltage (±)	10 V to 6 kV	2.5 %	EN 6200-4-4 IEC 61000-4-6
Rise Time	5 ns ± 30 %	0.81 ns	
Impulse Duration	50 ns ± 30 %	0.81 ns	Tektronix TDS 3052, Haefely PAT 50 / 1000 probes
Burst Duration	15 ms ± 20 %	0.81 ns	
Burst Period	300 ms ± 20 %	0.81 ns	
Repetition Rate			
0.125 kV	5 kHz ± 20 %	1.2 Hz	Tektronix TDS 3052
0.25 kV	5 kHz ± 20 %	1.2 Hz	
0.50 kV	5 kHz ± 20 %	1.2 Hz	
1.0 kV	5 kHz ± 20 %	1.2 Hz	
2.0 kV	2.5 kHz ± 20 %	1.2 Hz	
4.0 kV	2.5 kHz ± 20 %	1.2 Hz	
CDN –			
Phase			
-6 dBm	(-0.8 to 0.8)°	0.039°	CISPR 16-1-2, IEC 61000-4-6,
-10 dBm	(-0.12 to 0.12)°	0.035°	HP8751A, Type N calibration kit
-30 dBm	(-0.12 to 0.12)°	0.024°	
-40 dBm	(-0.12 to 0.12)°	0.12°	
-50 dBm	(-0.12 to 0.12)°	0.14°	
-60 dBm	(-0.3 to 0.3)°	0.70°	

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
CDN – (cont)			
Impedance	(5 to 100) Hz 100 Hz to 1 MHz (1 to 300) MHz (300 to 500) MHz	6.9 % 1.4 % 0.66 % 0.70 %	CISPR 16-1-2, IEC 61000-4-6, HP8751A, Type N calibration kit
Coupling Factor	10 kHz to 500 MHz	0.38 dB	
Current Probe – Transfer Impedance	10 kHz to 100 MHz 100 MHz to 1 GHz (1 to 1.2) GHz	0.25 dB 0.57 dB 1.3 dB	CISPR 16-1-2 Boonton 9242 w/ Boonton 952001B probes
LISN ³ –			
Insertion Loss	9 kHz to 1 GHz	0.38 dB	CISPR 16-1-2
Impedance	9 kHz to 1 GHz	4.9 %	HP8751A, HP8753C Verification kit
Phase	9 kHz to 1 GHz	2.8°	
SpO2/Pulse Oximeter –			
Beats Per Minute	60 bpm 200 bpm	1.3 bpm 2.4 bpm	Nelcor SRC-MAX
Pulse Oximetry (% SpO2)	(75 and 90) %	1.3 %	

IV. Dimensional

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Micrometers & Calipers ³	Up to 2 in (2 to 8) in (8 to 16) in (16 to 24) in	$4.4L + 3.2 \mu\text{in} + 0.6R$ $4.7L + 4.3 \mu\text{in} + 0.6R$ $5L + 5.3 \mu\text{in} + 0.6R$ $4.8L + 4.2 \mu\text{in} + 0.6R$	Gage blocks (Grade 1)
Gage Blocks	(0.005 to 13) in	$(3.4 + 0.94L) \mu\text{in}$	Pratt & Whitney Labmaster™

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Height Gages ³	Up to 2 in (2 to 8) in (8 to 16) in (16 to 24) in	$4.4L + 15 \mu\text{in} + 0.6R$ $4.7L + 16 \mu\text{in} + 0.6R$ $5L + 16 \mu\text{in} + 0.6R$ $4.8L + 16 \mu\text{in} + 0.6R$	Gage blocks (Grade 1)
Profilometers ³ – Fixed Points, Ra	16 μin 119.3 μin	3.8 μin 3.7 μin	Taylor Hobson surface standard blocks
Ring Gages	(0.04 to 14) in	$(22 + 3.5D) \mu\text{in}$	Pratt & Whitney Labmaster™
Pin Gages	(0.011 to 6) in	$(3.4 + 0.94D) \mu\text{in}$	Pratt & Whitney Labmaster™
Bore Gages – 3-Point	Up to 7.8 in	170 μin	3-Point bore gage master setting

V. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
DC Voltage ³ – Generate	(0 to 220) mV (0.22 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V (1000 to 10 000) V (10 000 to 40 000) V	9.0 $\mu\text{V/V} + 0.40 \mu\text{V}$ 5.3 $\mu\text{V/V} + 0.70 \mu\text{V}$ 3.6 $\mu\text{V/V} + 2.5 \mu\text{V}$ 3.6 $\mu\text{V/V} + 4.0 \mu\text{V}$ 5.1 $\mu\text{V/V} + 40 \mu\text{V}$ 6.7 $\mu\text{V/V} + 400 \mu\text{V}$ 0.015 % 0.041 %	Fluke 5720A HV supply w/source voltage monitored under measure
DC Voltage ³ – Generate Fixed Points	100 mV 1 V 10 V 100 V 1000 V	3.5 $\mu\text{V/V}$ 3.5 $\mu\text{V/V}$ 3.5 $\mu\text{V/V}$ 3.5 $\mu\text{V/V}$ 3.5 $\mu\text{V/V}$	Ratio metric techniques Fluke 752A, Fluke 10 DC reference standard

Parameter/Equipment	Range	CMC ^{2, 5, 6} (\pm)	Comments
DC Voltage ³ – Measure	(0 to 200) mV 200 mV to 2 V (2 to 20) V (20 to 200) V (200 to 1000) V (1 to 10) kV (10 to 35) kV (35 to 100) kV	7.8 μ V/V + 0.10 μ V 4.4 μ V/V + 0.40 μ V 3.6 μ V/V + 4.0 μ V 5.4 μ V/V + 40 μ V 8.2 μ V/V + 0.50 mV 0.012 % 0.045 % 0.057 %	Fluke 8508A Voltage divider & precision DMM Precision high voltage meter
DC Current ³ – Measure	(0 to 200) μ A 200 μ A to 2.0 mA (2.0 to 20) mA (20 to 200) mA 200 mA to 2 A (2 to 20) A (20 to 100) A (100 to 1000) A (1000 to 3000) A	13 μ A/A + 400 pA 13 μ A/A + 4.0 nA 14 μ A/A + 40 nA 38 μ A/A + 800 nA 0.018 % + 16 μ A 0.040 % + 400 μ A 0.054 % 0.26 % 0.30 %	Fluke 8508A Various current shunts
DC Current ³ – Generate	10 fA to 1 pA (1 to 10) pA (10 to 100) pA 100 pA to 1 nA (1 to 10) nA (10 to 100) nA 100 nA to 110 μ A (110 to 220) μ A 220 μ A to 2.2 mA (2.2 to 22) mA (22 to 220) mA 220 mA to 2.2 A (2.2 to 11) A (11 to 20) A (20 to 120) A (120 to 1000) A (1000 to 5000) A	2.9 % 1.8 % 1.8 % 1.8 % 1.8 % 1.7 % 1.6 % 49 μ A/A + 6.0 nA 37 μ A/A + 7.0 nA 38 μ A/A + 40 nA 48 μ A/A + 0.70 μ A 83 μ A/A + 12 μ A 0.040 % + 480 μ A 0.011 % + 1.0 mA 90 μ A/A + 6.0 mA 0.26 % 0.56 %	Pico ampere source Fluke 5720A Fluke 5725A amplifier Fluke 52120A 1 kA shunt Fluke 52120A w/current coils

Parameter/Range	Frequency	CMC ^{2, 6} (±)	Comments
AC Voltage ³ – Generate			
Up to 2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.026 % + 4.0 µV 0.015 % + 4.0 µV 0.013 % + 4.0 µV 0.023 % + 4.0 µV 0.051 % + 5.0 µV 0.11 % + 10 µV 0.14 % + 20 µV 0.27 % + 20 µV	Fluke 5720A
(2.2 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.027 % + 4.0 µV 0.013 % + 4.0 µV 0.013 % + 4.0 µV 0.023 % + 4.0 µV 0.057 % + 5.0 µV 0.11 % + 10 µV 0.15 % + 20 µV 0.30 % + 20 µV	
(22 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.025 % + 12 µV 95 µV/V + 7.0 µV 0.012 % + 7.0 µV 0.022 % + 7.0 µV 0.048 % + 17 µV 0.094 % + 20 µV 0.14 % + 25 µV 0.28 % + 45 µV	
220 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz (40 to 20 000) Hz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.025 % + 40 µV 95 µV/V + 15 µV 51 µV/V + 8.0 µV 78 µV/V + 10 µV 0.013 % + 30 µV 0.044 % + 80 µV 0.10 % + 200 µV 0.19 % + 300 µV	
(2.2 to 22) V	(10 to 20) Hz (20 to 40) Hz (40 to 20 000) Hz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.025 % + 400 µV 95 µV/V + 150 µV 50 µV/V + 50 µV 78 µV/V + 100 µV 0.012 % + 200 µV 0.031 % + 600 µV 0.10 % + 2.0 mV 0.19 % + 3.2 mV	

Parameter/Range	Frequency	CMC ^{2, 6} (±)	Comments
AC Voltage ³ – Generate (cont)			
(22 to 220) V	(10 to 20) Hz (20 to 40) Hz (40 to 20 000) Hz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.025 % + 4.0 mV 94 µV/V + 1.5 mV 57 µV/V + 600 µV 83 µV/V + 1.0 mV 0.018 % + 2.5 mV 0.091 % + 16 mV 0.44 % + 40 mV 0.80 % + 80 mV	Subject to 2.2 E ⁷ V-Hz limitation
(220 to 1100) V	(15 to 50) Hz (0.05 to 1) kHz	0.031 % + 16 mV 77 µV/V + 3.5 mV	
1100 V	40 Hz to 1.0 kHz (1 to 20) kHz (20 to 30) kHz	90 µV/V + 4.0 mV 0.017 % + 6.0 mV 0.06 % + 11 mV	5725A amplifier
750 V	(30 to 50) kHz (50 to 100) kHz	0.060 % + 11 mV 0.23 % + 45 mV	5725A amplifier
AC Voltage ³ – Measure			
Up to 2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.17 % + 1.3 µV 0.076 % + 1.3 µV 0.044 % + 1.3 µV 0.083 % + 2.0 µV 0.12 % + 2.5 µV 0.23 % + 4.0 µV 0.25 % + 8.0 µV 0.36 % + 8.0 µV	Fluke 5790A
(2.2 to 7) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.087 % + 1.3 µV 0.038 % + 1.3 µV 0.022 % + 1.3 µV 0.041 % + 2.0 µV 0.061 % + 2.5 µV 0.12 % + 4.0 µV 0.13 % + 8.0 µV 0.20 % + 8.0 µV	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
AC Voltage ³ – Measure (cont)			
(7 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.030 % + 1.3 µV 0.018 % + 1.3 µV 0.011 % + 1.3 µV 0.021 % + 2 µV 0.032 % + 2.5 µV 0.083 % + 4.0 µV 0.088 % + 8.0 µV 0.14 % + 8.0 µV	Fluke 5790A
(22 to 70) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.021 % + 1.5 µV 0.011 % + 1.5 µV 72 µV/V + 1.5 µV 0.012 % + 2.0 µV 0.026 % + 2.5 µV 0.048 % + 4.0 µV 0.060 % + 8.0 µV 0.092 % + 8.0 µV	
(70 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.019 % + 1.5 µV 83 µV/V + 1.5 µV 59 µV/V + 1.5 µV 93 µV/V + 2.0 µV 0.020 % + 2.5 µV 0.030 % + 4.0 µV 0.039 % + 8.0 µV 0.084 % + 8.0 µV	
(220 to 700) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.018 % + 1.5 µV 67 µV/V + 1.5 µV 34 µV/V + 1.5 µV 60 µV/V + 2.0 µV 86 µV/V + 2.5 µV 0.020 % + 4.0 µV 0.028 % + 8.0 µV 0.077 % + 8.0 µV	
700 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.017 % 57 µV/V 22 µV/V 54 µV/V 75 µV/V 0.017 % 0.024 % 0.071 %	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
AC Voltage ³ – Measure (cont)			
(2.2 to 7) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.017 % 59 µV/V 23 µV/V 55 µV/V 81 µV/V 0.019 % 0.034 % 0.094 %	Fluke 5790A
(7 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.017 % 58 µV/V 27 µV/V 56 µV/V 81 µV/V 0.020 % 0.034 % 0.095 %	
(22 to 70) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.017 % 59 µV/V 33 µV/V 67 µV/V 98 µV/V 0.021 % 0.036 % 0.095 %	
(70 to 220) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz	0.017 % 60 µV/V 31 µV/V 81 µV/V 0.011 % 0.021 % 0.041 %	
(220 to 700) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.018 % 85 µV/V 44 µV/V 0.012 % 0.040 %	
(700 to 1000) V	(20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	82 µV/V 40 µV/V 0.012 % 0.040 %	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
AC Voltage ³ – Measure (cont)			
(1 to 10) kV	(0.01 to 1) Hz (1 to 200) Hz (200 to 450) Hz	0.14 % 0.14 % 0.41 %	Precision high voltage meter
(10 to 30) kV	(0.01 to 1) Hz (1 to 200) Hz (200 to 450) Hz	0.14 % 0.08 % 0.52 %	
(30 to 70) kV	(0.01 to 1) Hz (1 to 70) Hz (70 to 200) Hz	0.32 % 0.15 % 1.1 %	
(70 to 100) kV	(50 to 60) Hz	0.66 %	AC voltage standard w/voltage divider & precision DMM
AC Current ³ – Generate			
Up to 220 µA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.026 % + 16 nA 0.017 % + 10 nA 0.014 % + 8.0 nA 0.029 % + 12 nA 0.11 % + 65 nA	Fluke 5720A
220 µA to 2.2 mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.026 % + 40 nA 0.017 % + 35 nA 0.013 % + 35 nA 0.021 % + 110 nA 0.11 % + 650 nA	
(2.2 to 22) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.026 % + 400 nA 0.017 % + 350 nA 0.013 % + 350 nA 0.021 % + 550 nA 0.11 % + 5.0 µA	
(22 to 220) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.026 % + 4.0 µA 0.017 % + 3.5 µA 0.013 % + 2.5 µA 0.021 % + 3.5 µA 0.11 % + 10 µA	
220 mA to 2.2 A	20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.028 % + 35 µA 0.046 % + 80 µA 0.71 % + 160 µA	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
AC Current ³ – Generate (cont)			
(2.2 to 11) A	40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.046 % + 170 µA 0.095 % + 380 µA 0.36 % + 750 µA	Fluke 5720A
(11 to 20.5) A	(45 to 100) Hz (0.1 to 1) kHz (1 to 5) kHz	0.11 % + 5.0 mA 0.12 % + 5.0 mA 2.4 % + 5.0 mA	Fluke 5720A w/5725 amplifier
(20.5 to 100) A	1 kHz 10 kHz 30 kHz 100 kHz	84 µA/A 0.012 % 0.013 % 0.024 %	Fluke A40B-100A
(100 to 550) A	(45 to 440) Hz	0.36 %	Fluke 5520A w/coil
(550 to 3000) A	10 Hz to 1 kHz	0.56 %	Fluke 52120A w/current coils
(3 to 6) kA	10 Hz to 1 kHz	0.56 %	
AC Current ³ – Measure			
Up to 200 µA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.034 % + 20 nA 0.035 % + 20 nA 0.068 % + 20 nA 0.57 % + 20 nA	Fluke 8508A
200 µA to 2 mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.033 % + 200 nA 0.029 % + 200 nA 0.066 % + 200 nA 0.40 % + 200 nA	
(2 to 20) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.034 % + 2.0 µA 0.030 % + 2.0 µA 0.066 % + 2.0 µA 0.40 % + 2.0 µA	
(20 to 200) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz	0.033 % + 20 µA 0.026 % + 20 µA 0.061 % + 20 µA	
200 mA to 2 A	10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.061 % + 200 µA 0.072 % + 200 µA 0.30 % + 200 µA	
(2 to 20) A	10 Hz to 2 kHz (2 to 10) kHz	0.091 % + 2.4 mA 0.26 % + 2.4 mA	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
AC Current ³ – Measure (cont)			
(20 to 100) A	(0 to 100) Hz	0.054 %	
(100 to 1000) A	(0 to 100) Hz	0.30 %	Fluke 8508A
(1 to 1.2) kA	(0 to 100) Hz	0.17 %	
(1.2 to 3) kA	(0 to 100) Hz	0.30 %	Various current shunts

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
Resistance ³ – Generate			
Ranges	(1.00 to 1000) MΩ	0.24 %	Biddle 72-6346-1
	(1000 to 10 000) MΩ	0.70 %	
	(10 to 100) GΩ	1.5 %	
Fixed Points	0.001 Ω	0.056 %	Short current shunt
	0.01 Ω	0.049 %	
	0.1 Ω	0.040 %	
	1.0 Ω	0.17 μΩ/Ω	Fluke 742A-1
	100 Ω	0.80 μΩ/Ω	Fluke 742-100
	10 kΩ	0.33 μΩ/Ω	Fluke 742A-10k
	1 Ω	98 μΩ/Ω + 40 μΩ	Fluke 5720A
	1.9 Ω	98 μΩ/Ω + 40 μΩ	
	10 Ω	26 μΩ/Ω + 40 μΩ	
	19 Ω	26 μΩ/Ω + 40 μΩ	
	100 Ω	11 μΩ/Ω + 40 μΩ	
	190 Ω	11 μΩ/Ω + 40 μΩ	
	1 kΩ	9.0 μΩ/Ω	
	1.9 kΩ	9.0 μΩ/Ω	
	10 kΩ	9.0 μΩ/Ω	
	19 kΩ	9.0 μΩ/Ω	
	100 kΩ	12 μΩ/Ω	
	190 kΩ	12 μΩ/Ω	
	1 MΩ	21 μΩ/Ω	
	1.9 MΩ	22 μΩ/Ω	
	10 MΩ	41 μΩ/Ω	
	19 MΩ	49 μΩ/Ω	
	100 MΩ	0.011 %	

Parameter/Equipment	Range	CMC ^{2, 5, 6} (\pm)	Comments
Resistance ³ – Generate (cont)			
Fixed Points	10 M Ω	0.14 %	Keithley 5155-7
	100 M Ω	0.14 %	Keithley 5155-8
	1 G Ω	0.14 %	Keithley 5155-9
	10 G Ω	0.16 %	Keithley 5155-10
	100 G Ω	0.59 %	Keithley 5155-11
	1 T Ω	2.1 %	Keithley 5155-12
Resistance ³ – Measure	(0 to 0.25) Ω	60 $\mu\Omega/\Omega$	Hart Scientific 1590
	(0.25 to 4.0) Ω	47 $\mu\Omega/\Omega$	
	(2.5 to 40) Ω	24 $\mu\Omega/\Omega$	
	(0 to 25) Ω	8.7 $\mu\Omega/\Omega$	
	(25 to 400) Ω	7 $\mu\Omega/\Omega$	
	(400 to 1000) Ω	13 $\mu\Omega/\Omega$	
	(1 to 25) k Ω	15 $\mu\Omega/\Omega$	
	(25 to 40) k Ω	14 $\mu\Omega/\Omega$	
	(40 to 100) k Ω	41 $\mu\Omega/\Omega$	
	(100 to 500) k Ω	0.015 %	
	(2 to 20) k Ω	7.7 $\mu\Omega/\Omega + 5.0$ m Ω	Fluke 8508A
	(20 to 200) k Ω	8 $\mu\Omega/\Omega + 50$ m Ω	
	(0.2 to 2) M Ω	10 $\mu\Omega/\Omega + 1.0$ Ω	
	(2 to 20) M Ω	23 $\mu\Omega/\Omega + 100$ Ω	
	(20 to 200) M Ω	77 $\Omega/\Omega + 10$ k Ω	
	(0.2 to 2) G Ω	0.063 % + 1.0 M Ω	
	(2 to 100) G Ω	0.55 %	Quadtech 1865
	(100 to 1000) G Ω	0.54 %	

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
Harmonic Distortion – Generate 10 Hz to 5 kHz Fundamental Frequency	(2 nd to 50 th) Harmonic, where frequency x harmonic ≤ 10 kHz	0.21 %	Fluke 5520A
Harmonic Distortion – Measure 20 Hz to 20 kHz Fundamental Frequency	(2 nd to 64 th) Harmonic, where frequency x harmonic ≤ 50 kHz Total Harmonic Distortion	0.13 % 0.13 %	Keithley 2016-P
Electrical Calibration of Thermocouples ³ – Generate & Measure Type B (600 to 800) °C (800 to 1000) °C (1000 to 1550) °C (1550 to 1820) °C Type C (0 to 150) °C (150 to 650) °C (650 to 1000) °C (1000 to 1800) °C (1800 to 2316) °C Type E (-250 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1000) °C Type J (-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1200) °C Type K (-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1000) °C (1000 to 1372) °C	0.34 °C 0.26 °C 0.23 °C 0.26 °C 0.23 °C 0.20 °C 0.24 °C 0.39 °C 0.66 °C 0.39 °C 0.13 °C 0.11 °C 0.13 °C 0.16 °C 0.21 °C 0.13 °C 0.11 °C 0.13 °C 0.18 °C 0.26 °C 0.14 °C 0.12 °C 0.20 °C 0.31 °C	Fluke 5520A	

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of Thermocouples ³ – Generate & Measure (cont)			
Type L	(-200 to -100) °C (-100 to 800) °C (800 to 900) °C	0.29 °C 0.20 °C 0.14 °C	Fluke 5520A
Type N	(-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 410) °C (410 to 1300) °C	0.31 °C 0.17 °C 0.15 °C 0.14 °C 0.21 °C	
Type R	(0 to 250) °C (250 to 400) °C (400 to 1000) °C (1000 to 1767) °C	0.44 °C 0.27 °C 0.26 °C 0.31 °C	
Type S	(0 to 250) °C (250 to 1000) °C (1000 to 1400) °C (1400 to 1767) °C	0.37 °C 0.28 °C 0.29 °C 0.36 °C	
Type T	(-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.49 °C 0.19 °C 0.13 °C 0.11 °C	
Type U	(-200 to 0) °C (0 to 600) °C	0.44 °C 0.21 °C	

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of RTDs ³ – Measure & Generate			
Type Pt 385, 100 Ω	(-200 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C (630 to 800) °C	0.047 °C 0.055 °C 0.075 °C 0.078 °C 0.11 °C 0.18 °C	Fluke 5520A 4 wire compensation
Type Pt 3926, 100 Ω	(-200 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.045 °C 0.056 °C 0.071 °C 0.081 °C 0.093 °C	
Type Pt 3916, 100 Ω	(-200 to -190) °C (-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.19 °C 0.034 °C 0.042 °C 0.049 °C 0.062 °C 0.063 °C 0.072 °C 0.078 °C 0.18 °C	
Type Pt 385, 200 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.047 °C 0.034 °C 0.039 °C 0.047 °C 0.093 °C 0.10 °C 0.11 °C 0.12 °C	
Type Pt 385, 500 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.039 °C 0.041 °C 0.042 °C 0.049 °C 0.064 °C 0.064 °C 0.085 °C 0.085 °C	

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
Electrical Calibration of RTDs ³ – Measure & Generate (cont)			
Type Pt 385, 1000 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.035 °C 0.027 °C 0.035 °C 0.042 °C 0.047 °C 0.056 °C 0.060 °C 0.18 °C	Fluke 5520A 4 wire compensation
Type PtNi, 120 Ω (Ni 120)	(-80 to 0) °C (0 to 100) °C (100 to 260) °C	0.063 °C 0.063 °C 0.11 °C	
Type Cu 427, 10 Ω	(-100 to 260) °C	0.23 °C	
DC Power ³ – Measuring Equipment			
33 mV to 1020 V	(0.33 to 330) mA (0.33 to 3) A (3 to 20.5) A	0.018 % 0.017 % 0.054 %	Fluke 5520A

Parameter/Range	Frequency	CMC ^{2, 5, 6} (\pm)	Comments
Capacitance ³ – Generate			
Fixed Points	1 kHz 1 kHz	14 μ F/F 16 μ F/F	GenRad 1404-A GenRad 1404-B
1 pF	100 Hz to 1 kHz 1 kHz to 1 MHz (1 to 2) MHz (2 to 3) MHz (3 to 4) MHz (4 to 5) MHz (5 to 10) MHz (10 to 13) MHz	45 μ F/F 91 μ F/F 0.023 % 0.042 % 0.064 % 0.089 % 0.25 % 0.37 %	HP 1638XX standard capacitor
10 pF	100 Hz to 1 kHz 1 kHz to 1 MHz (1 to 2) MHz (2 to 3) MHz (3 to 4) MHz (4 to 5) MHz (5 to 10) MHz (10 to 13) MHz	39 μ F/F 39 μ F/F 40 μ F/F 44 μ F/F 47 μ F/F 57 μ F/F 0.013 % 0.016 %	
100 pF	100 Hz to 1 kHz 1 kHz to 1 MHz (1 to 2) MHz (2 to 3) MHz (3 to 4) MHz (4 to 5) MHz (5 to 10) MHz (10 to 13) MHz	39 μ F/F 40 μ F/F 48 μ F/F 68 μ F/F 94 μ F/F 0.014 % 0.033 % 0.051 %	
1000 pF	100 Hz to 1 kHz 1 kHz to 1 MHz (1 to 2) MHz (2 to 3) MHz (3 to 4) MHz (4 to 5) MHz (5 to 10) MHz (10 to 13) MHz	41 μ F/F 64 μ F/F 0.015 % 0.028 % 0.044 % 0.061 % 0.19 % 0.28 %	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
Capacitance ³ – Generate (cont)			
Fixed Points			
0.001 µF	20 Hz to 1 kHz	1.2 pF	GenRad 1409 series
0.01 µF	20 Hz to 1 kHz	13 pF	
0.1 µF	20 Hz to 1 kHz	120 pF	
1.0 µF	20 Hz to 1 kHz	1.1 nF	
0.02 µF	20 Hz to 1 kHz	23 pF	
0.005 µF	20 Hz to 1 kHz	7.1 pF	
0.05 µF	20 Hz to 1 kHz	56 pF	
1000 pF	1 kHz	14 µF/F	GenRad 1404-A
100 PF	1 kHz	16 µF/F	GenRad 1404-B
(0.19 to 0.3999) nF	10 Hz to 10 kHz	0.51 % + 0.010 nF	Fluke 5520A
(0.4 to 1.0999) nF	10 Hz to 10 kHz	0.51 % + 0.010 nF	
(1.1 to 3.29) nF	10 Hz to 3 kHz	0.51 % + 0.010 nF	
(3.3 to 10.9) nF	10 Hz to 1 kHz	0.27 % + 0.010 nF	
(11 to 32.9999) nF	10 Hz to 1 kHz	0.27 % + 0.10 nF	
(33 to 109.9) nF	10 Hz to 1 kHz	0.27 % + 0.10 nF	
(110 to 329.999) nF	10 Hz to 1 kHz	0.27 % + 0.30 nF	
(0.33 to 1.09) µF	(10 to 600) Hz	0.27 % + 1.0 nF	
(1.1 to 3.299 99) µF	(10 to 300) Hz	0.27 % + 3.0 nF	
(3.3 to 10.9999) µF	(10 to 150) Hz	0.27 % + 10 nF	
(11 to 32.9999) µF	(10 to 120) Hz	0.41 % + 30 nF	
(33 to 109.999) µF	(10 to 80) Hz	0.46 % + 100 nF	
(110 to 329.999) µF	(10 to 50) Hz	0.46 % + 300 nF	
(0.3 to 1.099 99) mF	(10 to 20) Hz	0.46 % + 1.0 µF	
(1.1 to 3.2999) mF	(0 to 6) Hz	0.46 % + 3.0 µF	
(3.3 to 10.9999) mF	(0 to 2) Hz	0.46 % + 10 µF	
(11 to 32.9999) mF	(0 to 0.6) Hz	0.76 % + 30 µF	
(33 to 110) mF	(0 to 0.2) Hz	1.1 % + 100 µF	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
Capacitance ³ – Measure			
Fixed Points			
1 pF	(0.1 to 1) kHz (1 to 10) kHz	12 % 1.2 %	Agilent E4980A
10 pF	(20 to 1000) Hz (1 to 10) kHz (10 to 100) kHz (0.1 to 2) MHz	12 % 1.2 % 0.13 % 0.35 %	
100 pF	(20 to 100) Hz (0.1 to 1) kHz 1.0 kHz to 2 MHz	12 % 1.2 % 0.12 %	
1 nF	(20 to 100) Hz 100 Hz to 1 MHz (1 to 2) MHz	1.2 % 0.12 % 0.36 %	
10 nF	(20 to 100) Hz 100 Hz to 100 kHz 100 kHz to 2 MHz	0.35 % 0.12 % 0.35 %	
100 nF	20 Hz to 10 kHz 10 kHz to 2 MHz	0.12 % 0.35 %	
1.0 µF	20 Hz to 10 kHz 10 kHz to 2 MHz	0.12 % 0.35 %	
10.0 µF	(20 to 1000) Hz (1 to 100) kHz (0.1 to 2) MHz	0.12 % 0.35 % 1.2 %	
100.0 µF	100 Hz to 10 kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz	0.35 % 1.2 % 7.0 % 12 %	
1.0 mF	(20 to 1000) Hz (1 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz	0.35 % 1.2 % 7.0 % 12 %	
10 mF	(20 to 100) Hz (0.1 to 1) kHz (1 to 10) kHz (10 to 100) kHz	0.81 % 1.2 % 9.3 % 12 %	

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
Capacitance ³ – Measure (cont) Fixed Points 100 mF	(20 to 100) Hz 100 Hz to 10 kHz	5.8 % 12 %	Agilent E4980A

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
Inductance ³ – Generate @ 1000 Hz, Generate Equipment Fixed Points	100 µH to 1.111 H (100 µH Steps) 200 µH 500 µH 1 mH 5 mH 10 mH 50 mH 500 mH 2 H	2.4 % 0.15 % 0.15 % 0.15 % 0.15 % 0.15 % 0.15 % 0.15 % 0.15 %	GenRad 1490-F decade inductance box GenRad 1482-x standard inductors

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
Inductance ³ – Measure 1 pH to 1 mH (1 to 10) mH	(20 to 100) Hz (0.1 to 1) kHz (1 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz (20 to 100) Hz (0.1 to 1) kHz (1 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz	0.35 % 0.12 % 0.12 % 0.12 % 0.12 % 0.41 % 0.35 % 0.12 % 0.14 % 0.12 % 0.12 % 1.7 %	Agilent E4980A

Parameter/Range	Frequency	CMC ^{2, 5, 6} (±)	Comments
Inductance ³ – Measure (cont)			
(10 to 100) mH	(20 to 100) Hz (0.1 to 1) kHz (1 to 10) kHz	0.35 % 0.12 % 0.12 %	Agilent E4980A
100 mH to 1 H	(20 to 100) Hz (0.1 to 1) kHz (1 to 10) kHz	0.12 % 0.12 % 0.12 %	
(1 to 10) H	(20 to 100) Hz (0.1 to 1) kHz	0.12 % 0.12 %	
Oscilloscopes ³ –			
Voltage (50 Ω)	(1 to 556) mV 556 mV to 5.56 V	0.078 % + 10 µV 0.78 % + 10 µV	Fluke 9500B w/Fluke heads 9630 & 9560
Sweep Time	9 ns to 55 s	2.3 µs/s	
Rise Time	150 ps to 100 ms	16 ps	
Bandwidth	0.1 Hz to 6.0 GHz	4.4 % flatness	
Phase Angle ³ – Generate			
(0 to 360)°	(10 to 65) Hz (65 to 500) Hz 500 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.079° 0.19° 0.39° 2.0° 3.9° 7.8°	Fluke 5520A
Synchro/Resolver Indicators –			
(0 to 360)°	400 Hz	0.000 70°	Gertsch 922711-1

VI. Electrical – RF/Microwave

Parameter/Equipment	Range	CMC ^{2,5,6} (±)	Comments
AC Power ³ – Measuring Equipment			
(33 to 330) mV Power Factor = 1	(3.3 to 9) mA (9 to 33) mA (33 to 90) mA (90 to 330) mA (330 to 900) mA 900 mA to 2.2 A (2.2 to 4.5) A (4.5 to 20.5) A	0.15 % 0.11 % 0.15 % 0.14 % 0.16 % 0.16 % 0.14 % 0.15 %	Fluke 5520A frequency (45 to 65) Hz
330 mV to 1020 V Power Factor = 1	(3.3 to 9) mA (9 to 33) mA (33 to 90) mA (90 to 330) mA (330 to 900) mA 900 mA to 2.2 A (2.2 to 4.5) A (4.5 to 20.5) A	0.13 % 0.10 % 0.13 % 0.10 % 0.15 % 0.13 % 0.14 % 0.11 %	
Attenuation ³ – Measure			
2.5 MHz to 26.5 GHz	(0 to 10) dBm (-10 to 0) dBm (-20 to -10) dBm (-30 to -20) dBm (-40 to -30) dBm (-50 to -40) dBm (-60 to -50) dBm (-70 to -60) dBm (-80 to -70) dBm (-90 to -80) dBm (-100 to -90) dBm (-110 to -100) dBm (-120 to -110) dBm (-127 to -120) dBm	0.10 dB 0.10 dB 0.13 dB 0.15 dB 0.17 dB 0.20 dB 0.22 dB 0.24 dB 0.27 dB 0.29 dB 0.31 dB 0.33 dB 0.39 dB 0.61 dB	HP 8902A, Agilent 11793A

Parameter/Range	Frequency	CMC ^{2, 5, 6, 8} (\pm)	Comments
Tuned RF Power ³ – Relative Measure (0 to 10) dBm (-10 to 0) dBm (-20 to -10) dBm (-30 to -20) dBm (-40 to -30) dBm (-50 to -40) dBm (-60 to -50) dBm (-70 to -60) dBm (-80 to -70) dBm (-90 to -80) dBm (-100 to -90) dBm (-110 to -100) dBm (-120 to -110) dBm (-127 to -120) dBm	2.5 MHz to 26.5 GHz	0.10 dB 0.10 dB 0.13 dB 0.15 dB 0.17 dB 0.20 dB 0.22 dB 0.24 dB 0.27 dB 0.29 dB 0.31 dB 0.33 dB 0.39 dB 0.61 dB	HP 8902A, Agilent 11793A
Tuned RF Power ³ – Absolute Measure (0 to +10) dBm (-10 to 0) dBm (-20 to -10) dBm (-30 to -20) dBm (-40 to -30) dBm (-50 to -40) dBm (-60 to -50) dBm (-70 to -60) dBm (-80 to -70) dBm (-90 to -80) dBm (-100 to -90) dBm (-110 to -100) dBm (-120 to -110) dBm (-127 to -120) dBm	2.5 MHz to 26.5 GHz	0.17 dB 0.17 dB 0.19 dB 0.22 dB 0.24 dB 0.26 dB 0.28 dB 0.31 dB 0.33 dB 0.35 dB 0.37 dB 0.40 dB 0.45 dB 0.67 dB	HP 8902A, Agilent 11793A
RF Power ³ – Measure (-120 to 30) dBm	100 kHz to 26 GHz	0.17 dB	HP 8902A
RF Power – 1 mW – Measure	(0.10 to 10) MHz (0.01 to 10) GHz (10 to 18) GHz	0.93 % 1.3 % 1.6 %	Tegam F1130A, 1830A

Parameter/Range	Frequency	CMC ^{2, 5, 6, 8} (\pm)	Comments
Calibration Factor	(0.10 to 0.20) MHz (0.30 to 40) MHz (0.05 to 2.0) GHz (2.1 to 3.6) GHz (3.7 to 4.6) GHz (4.8 to 10) GHz (12 to 18) GHz	0.65 % 0.58 % 0.57 % 0.59 % 0.61 % 0.66 % 0.78 %	Tegam F1130A, 1830A
Reflection Co-Efficient – Magnitude	9.0 kHz to 6.0 GHz	4.9 %	VNA
AM Modulation – Measure Rate: (0.05 to 10) kHz Depth: (5.0 to 99) % Rate: (0.02 to 10) kHz Depth: Up to 99 % Rate: (0.05 to 50) kHz Depth: (5.0 to 99) % Rate: 20 Hz to 0.10 MHz Depth: Up to 99% Rate: (0.05 to 50) kHz Depth: (5.0 to 99) % Rate: 20 Hz to 0.10 MHz Depth: Up to 99 %	(0.15 to 10) MHz (0.15 to 10) MHz (0.01 to 1.3) GHz (0.01 to 1.3) GHz (1.3 to 26.5) GHz (0.01 to 26.5) GHz	0.024 AM + 0.10 % 0.036 AM + 0.10 % 0.013 AM + 0.10 % 0.036 AM + 0.10 % 0.018 AM + 0.10 % 0.036 AM + 0.10 %	HP8902A

Parameter/Range	Frequency	CMC ^{2, 5, 6, 8} (\pm)	Comments
FM Modulation – Measure			
Rate: (0.02 to 10) kHz Deviation: \leq 40 kHz	(0.25 to 10) MHz: Up to 4.0 kHz _{peak} FM (4.0 to 40) kHz _{peak} FM	0.023 FM + 1.0 Hz _{peak} 0.023 FM + 10 Hz _{peak}	HP8902A
Rate: 50 Hz to 0.10 MHz Deviation: \leq 400 kHz	(0.01 to 1.3) GHz: Up to 4.0 kHz _{peak} FM (4.0 to 40) kHz _{peak} FM (0.04 to 0.40) MHz _{peak} FM	0.012 FM + 1.0 Hz _{peak} 0.012 FM + 10 Hz _{peak} 0.012 FM + 0.01 kHz _{peak}	
Rate: 50 Hz to 0.10 MHz Deviation: \leq 400 kHz	(0.01 to 27) GHz: Up to 4.0 kHz _{peak} FM (4.0 to 40) kHz _{peak} FM (0.04 to 0.40) MHz _{peak} FM	0.012 FM + 1.0 Hz _{peak} 0.012 FM + 10 Hz _{peak} 0.012 FM + 0.01 kHz _{peak}	
Rate: 20 Hz to 0.20 MHz Deviation: \leq 400 kHz	(0.01 to 1.3) GHz: Up to 4.0 kHz _{peak} FM (4.0 to 40) kHz _{peak} FM (0.04 to 0.40) MHz _{peak} FM	0.058 FM + 1.0 Hz _{peak} 0.058 FM + 10 Hz _{peak} 0.058 FM + 0.01 kHz _{peak}	
Rate: 20 Hz to 0.20 MHz Deviation: \leq 400 kHz	(0.01 to 27) GHz: Up to 4.0 kHz _{peak} FM (4.0 to 40) kHz _{peak} FM (0.04 to 0.40) MHz _{peak} FM	0.058 FM + 1.0 Hz _{peak} 0.058 FM + 10 Hz _{peak} 0.058 FM + 0.01 kHz _{peak}	
Phase Modulation – Measure			
Rate: (0.20 to 10) kHz Rate: (0.20 to 20) kHz Rate: (0.20 to 20) kHz	(0.15 to 10) MHz (0.01 to 1.3) GHz (1.3 to 27) GHz	0.046 PM + 0.010 rad 0.035 PM + 0.010 rad 0.035 PM + 0.010 rad	HP8902A

VII. Fluid

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Volume – Pipettes	(0 to 100) µL (100 to 500) µL (0.5 to 1) mL (1 to 5) mL	0.014 % + 0.60R 40 µL/L + 0.60R 32 µL/L + 0.60R 29 µL/L + 0.60R	Gravimetric calibration using Sartorius balance & ANSI/ASTM E617 Class 1 weights

VIII. Fluid Quantities

Parameter/Equipment	Range	CMC ^{2, 4, 5, 8} (±)	Comments
Mass Flow – Measuring Equipment	(1 to 5) SCCM (5 to 50) SCCM (100 to 1000) SCCM (1 to 10) SLPM (3 to 50) SLPM (50 to 300) SLPM (120 to 1200) SLPM (400 to 4000) SLPM	0.25 % + 0.60R 0.24 % + 0.60R 0.26 % + 0.60R 0.29 % + 0.60R 0.25 % + 0.60R 0.25 % + 0.60R 0.25 % + 0.60R 0.25 % + 0.60R	DHI molbox w/molbloc
Viscosity Meters ³	100 cps 1000 cps 12 500 cps 100 000 cps	(0.28 + 0.60R) cps (3.4 + 0.60R) cps (55 + 0.60R) cps (480 + 0.60R) cps	Cannon/Brookfield standard solutions

IX. Mechanical

Parameter/Equipment	Range	CMC ^{2, 4, 5, 8} (\pm)	Comments
Pressure ³ – Measuring Equipment, Hydraulic & Pneumatic	(2 to 700) psig (700 to 1100) psig (1100 to 5800) psig (5800 to 10 100) psig (10 100 to 16 000) psig (16 000 to 20 000) psig (20 000 to 40 000) psig (0 to 23.2) psia	0.002 % 76 μ Pa/Pa + 2.5 Pa 78 μ Pa/Pa + 13 Pa 84 μ Pa/Pa + 50 Pa 87 μ Pa/Pa + 50 Pa 12 psi 42 psi 0.013 %	Ruska 2465A w/2460-706 DHI PG 7202 w/PC-7200-100 w/PC-7200-500 w/PC-7200-2 Additel pressure gauges DHI RPM4
Mass ³	(0.001 to 6) g (1 to 500) g (5 to 1000) g (0.01 to 40) kg	16 μ g 25 μ g 2.9 mg 83 mg	Sartorius CCE6 Sartorius CC-500 Sartorius CCE-1201 Sartorius CC-30002
Scales & Balances ³	40 kg 30 kg 20 kg 10 kg 5 kg 1 kg 500 g 200 g 100 g 50 g 20 g 10 g 5 g 1 g 500 mg 100 mg 10 mg 1 mg	190 mg + 0.60R 130 mg + 0.60R 46 mg + 0.60R 62 mg + 0.60R 58 mg + 0.60R 3.0 mg + 0.60R 1.6 mg + 0.60R 0.57 mg + 0.60R 0.28 mg + 0.60R 140 μ g + 0.60R 88 μ g + 0.60R 62 μ g + 0.60R 41 μ g + 0.60R 41 μ g + 0.60R 18 μ g + 0.60R 18 μ g + 0.60R 18 μ g + 0.60R 18 μ g + 0.60R	Reference weights

Parameter/Equipment	Range	CMC ^{2, 4, 5, 8} (\pm)	Comments
Torque ³ – Measure Wrenches, Screwdrivers & Watches	(1 to 8) in·ozf (8 to 40) in·ozf (2.5 to 10) in·lbf (10 to 50) in·lbf (50 to 250) in·lbf (250 to 750) in·lbf (62.5 to 250) ft·lbf (250 to 1000) ft·lbf	1.2 % 0.63 % 0.57 % 0.77 % 0.63 % 0.65 % 1.2 % 0.71 %	Torque mate 2000
Torque – Measuring Equipment Transducers	(1 to 40) in·ozf (2.5 to 50) in·lbf (50 to 180) in·lbf (15 to 250) ft·lbf (250 to 1000) ft·lbf	0.058 % 0.055 % 0.042 % 0.044 % 0.085 %	Lever arms & traceable hanging weights
RPM ³ – Measure	(1 to 3000) RPM	0.11 RPM	Frequency counter w/ IR sensor
RPM ³ – Generate Optical	(1 to 100 000) RPM	0.17 RPM + 0.60R	Fluke 5520A w/ LED fixture
RPM ³ – Contact Meters	(1 to 3000) RPM	0.11 RPM + 0.60R	Frequency counter/motor
Air Velocity – Measuring Equipment	(25 to 7500) fpm	1.2 %	Wind tunnel & omega differential pressure sensor, model WT4401S
Accelerometers ³	160 Hz 10 Hz to 4 kHz (4 to 7) kHz (7 to 12.8) kHz	0.61 % 0.68 % 0.79 % 1.4 %	Reference accelerometer
Force – Measure Tension & Compression	(0 to 2500) lbf (2500 to 30 000) lbf (25 000 to 60 000) lbf	0.34 lbf 3.3 lbf 720 lbf	Morehouse tension & compression Tinius Olsen Super-L w/computer display

Parameter/Equipment	Range	CMC ² (\pm)	Comments
“Direct Verification” of Durometers ³ –			
Spring Force	A, B, O, D, C, DO scales	0.52 duro points	Durocalibrator
Indenter Display	(0 to 100) duro units	0.58 duro units	Gage blocks
Magnetics – Gauss Meters	54.8 Gauss 995.8 Gauss 4940 Gauss	0.20 Gauss 2.9 Gauss 9.5 Gauss	MII F343-50 MII F062-1K MII F062-5K

X. Optical Radiation

Parameter/Equipment	Range	CMC ^{2, 5, 8} (\pm)	Comments
Photometric – Measure ³	(1 to 10 000) fc	4.7 %	Radiometer

XI. Thermodynamic

Parameter/Equipment	Range	CMC ^{2, 8} (\pm)	Comments
Temperature – Measuring Equipment, Fixed Points	0.01 °C 29.7646 °C	0.0017 °C 0.0047 °C	Triple point water cell Melting point of Gallium cell

Parameter/Equipment	Range	CMC ^{2, 4, 5, 8} (\pm)	Comments
Dew Point ³ – Measuring Equipment	(-20 to 60) °C	0.10 °C	Thunder Scientific 1200/2500
Infrared Thermometers – Hart Furnace	(-15 to 0) °C (0 to 100) °C (100 to 120) °C (120 to 200) °C (200 to 350) °C (350 to 500) °C (500 to 1200) °C	1.2 °C 1.4 °C 1.3 °C 2.1 °C 2.5 °C 2.9 °C 8.1 °C	Fluke 4181/4180 $\epsilon = 0.9$ to 1.0 $\lambda = (8$ to 14) μm Fluke 9150 furnace w/Hart 1529 & Type S thermocouple
Temperature ³ – Measure & Measuring Equipment	(-80 to 110) °C (110 to 550) °C (550 to 1200) °C	0.011 °C + 0.60R 0.042 °C + 0.60R 0.59 °C + 0.60R	Fluke 7381 precision bath w/Hart 1594A & 5698 SPRT Isotech medusa furnace, Fluke 9150 furnace w/Hart 1529 & Type S thermocouple
Humidity ³ – Measuring Equipment	(10 to 95) % RH	0.51 %	Thunder Scientific 2500
Humidity – Measure ³	(10 to 90) % RH	1.7 % RH	Vaisala HumiCap (on-site only)
Temperature	(90 to 100) % RH	1.8 % RH	
	(-40 to 180) °C	(1.5 + 0.015X) % RH	X = reading

XII. Time & Frequency

Parameter/Equipment	Range	CMC ^{2, 4, 8} (\pm)	Comments
Frequency ³ – Measure Equipment	0.05 Hz to 10 MHz 10 MHz to 4 GHz (4 to 26) GHz	15 parts in 10^{12} Hz 21 parts in 10^{12} Hz 27 parts in 10^{12} Hz	GPS reference
Frequency – Measure	0.05 Hz to 2.7 GHz (2.7 to 20) GHz	25 parts in 10^{12} Hz 60 parts in 10^{12} Hz	Frequency counters w/external reference
Stopwatches & Timers	Up to 24 hr	0.05 sec/day + 0.60R	Timometer

¹ This laboratory offers commercial calibration service and field calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ This laboratory performs field calibration activities for these parameters. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ In the statement of CMC; L is the numerical value of the nominal length of the device measured in inches; R is the numerical value of the resolution of the device in its respective units; D is the diameter of the device in inches

⁵ In the statement of CMC, percentages are read as percent of reading/output, unless otherwise noted.

⁶ The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC are expressed as either a specific value that covers the full range or as a fraction or percent of the reading plus a fixed floor specification.

⁷ This scope meets A2LA's *P112 Flexible Scope Policy*.

⁸ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.



Accredited Laboratory

A2LA has accredited

BROADVIEW INSTRUMENTATION SERVICES, INC.

Valley View, OH

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and the requirements of ANSI/NCSL Z540.3-2006 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 25th day of March 2021.

A blue ink signature of a person's name, appearing to read "John Doe". It is positioned above a horizontal line.

Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 2046.01
Valid to March 31, 2023

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.